



CHINA NATIONAL ACCREDITATION SERVICE FOR CONFORMITY ASSESSMENT
SCHEDULE OF ACCREDITATION CERTIFICATE



No. CNAS L20336

The scope of the accreditation in Chinese remains the definitive version.

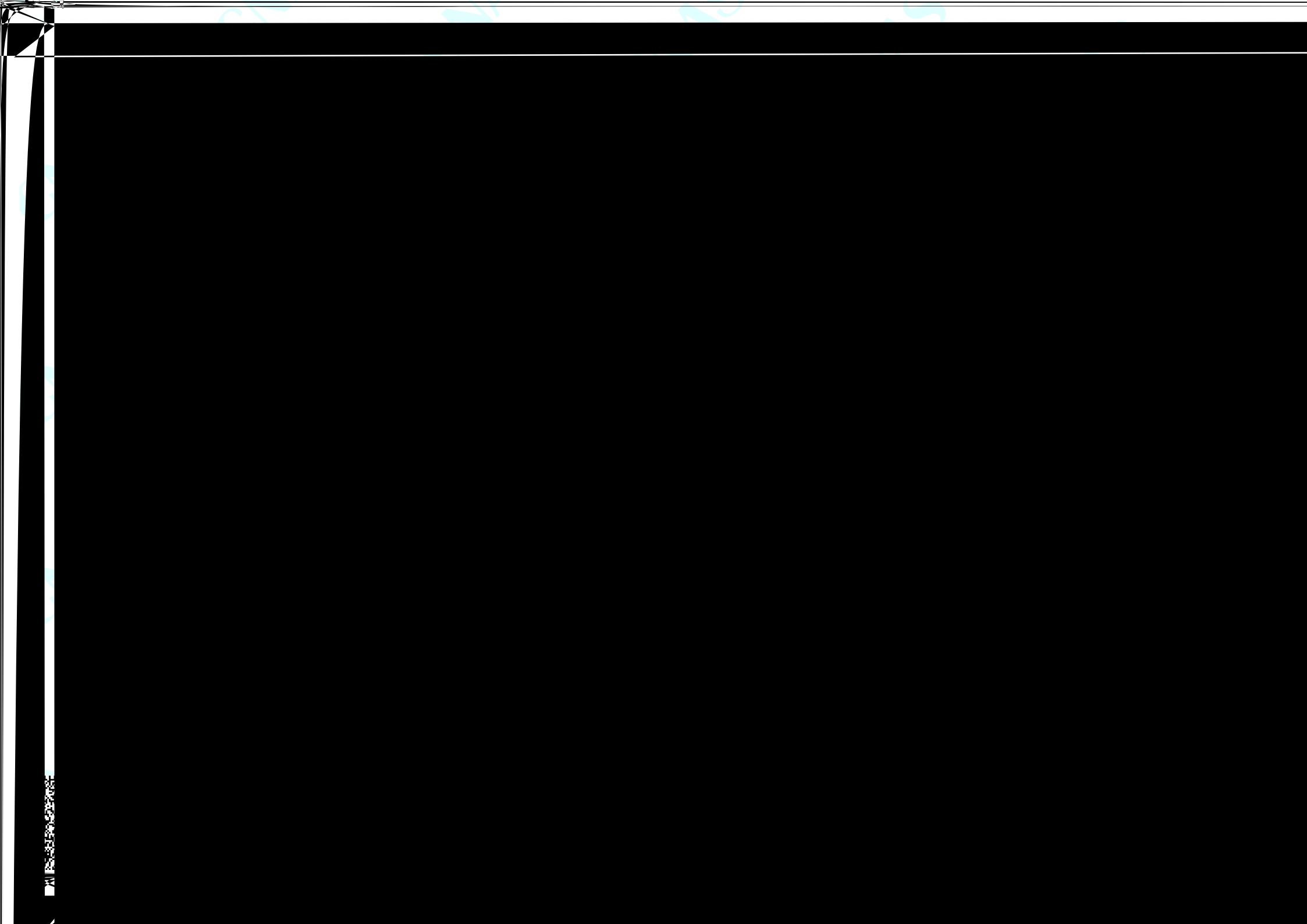


INTERNATIONAL ACCREDITATION SERVICE FOR CONFORMITY ASSESSMENT
SCHEDULE OF ACCREDITATION CERTIFICATE



No. CNAS L20336

The scope of the accreditation in Chinese remains the definitive version.



				2021 Tab2 B2	ature:(50 ~175 , Voltage:(5 V~2000V). Rental equipment is included.	
		3	HAST	FAILURE MECHANISM BASEDSTRESS TEST QUALIFICATIONFORDISCRETE SEMICONDUCTORSIN AUTOMOTIVE APPLICATIONS AEC-Q101-Rev-E March 1, 2021 Tab2 A2	Accredited only for: Temper ature:130 ,Humidity: 85%RH,Pre ssure:230k Pa,Voltage: (5V~1200V). Rental equipment is included.	2025-05-26
		4	H3TRB	FAILURE MECHANISM BASEDSTRESS TEST QUALIFICATIONFORDISCRETE SEMICONDUCTORSIN AUTOMOTIVE APPLICATIONS AEC-Q101-Rev-E March 1, 2021 Tab2 A2 alt	Accredited only for: Temper ature:85 , Humidity:8 5%RH,Volt age:(5V~12 00V). Rental equipment	2025-05-26



No. CNAS L20336

The scope of the accreditation in Chinese remains the definitive version.



NATIONAL ACCREDITATION SERVICE FOR CONFORMITY ASSESSMENT
SCHEDULE OF ACCREDITATION CERTIFICATE



The scope of the accreditation in Chinese remains the definitive version.





INTERNATIONAL ACCREDITATION SERVICE FOR CONFORMITY ASSESSMENT
SCHEDULE OF ACCREDITATION CERTIFICATE



No. CNAS L20336

The scope of the accreditation in Chinese remains the definitive version.

--	--	--	--	--	--

65 ~150

Rental
equipment
is included.
Only
measure: Te
mperature:

65 ~150 2025-05-26

Rental
equipment
is included.
Rental
equipment.

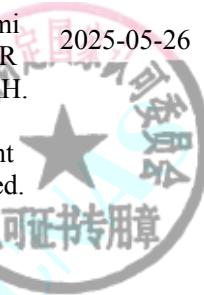
2025-05-26

Accredited
only
for: Temper
ature: 60 ~

85 ,Humi
dity: 60%R
H~85%RH.

2025-05-26

Rental
equipment
is included.



CHINA NATIONAL ACCREDITATION SERVICE FOR CONFORMITY ASSESSMENT
SCHEDULE OF ACCREDITATION CERTIFICATE

FAILURE MECHANISM BASED STRESS TEST
QUALIFICATION FOR DISCRETE SEMICONDUCTORS IN
AUTOMOTIVE APPLICATIONS AEC-Q101-Rev-E March 1,
2021 Tab2 A4

11 AM

Acoustic Microscopy for Non-Hermetic Encapsulated Electronic
Devices J-STD-035A December, 2022

12 TH

Steady-State Temperature-Humidity Bias Life Test JESD22-
A101D.01 January, 2021

13 WBP

MECHANICAL TEST METHODS FOR SEMICONDUCTOR

No. CNAS L20336

9

11

The scope of the accreditation in Chinese remains the definitive version.



在线扫码获取验证



INTERNATIONAL ACCREDITATION SERVICE FOR CONFORMITY ASSESSMENT
SCHEDULE OF ACCREDITATION CERTIFICATE



No. CNAS L20336

The scope of the accreditation in Chinese remains the definitive version.

